

MITSUBISHI HVIGBT MODULES  
**CM600HG-130H**

3rd-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

HIGH POWER SWITCHING USE  
 INSULATED TYPE

**CM600HG-130H**



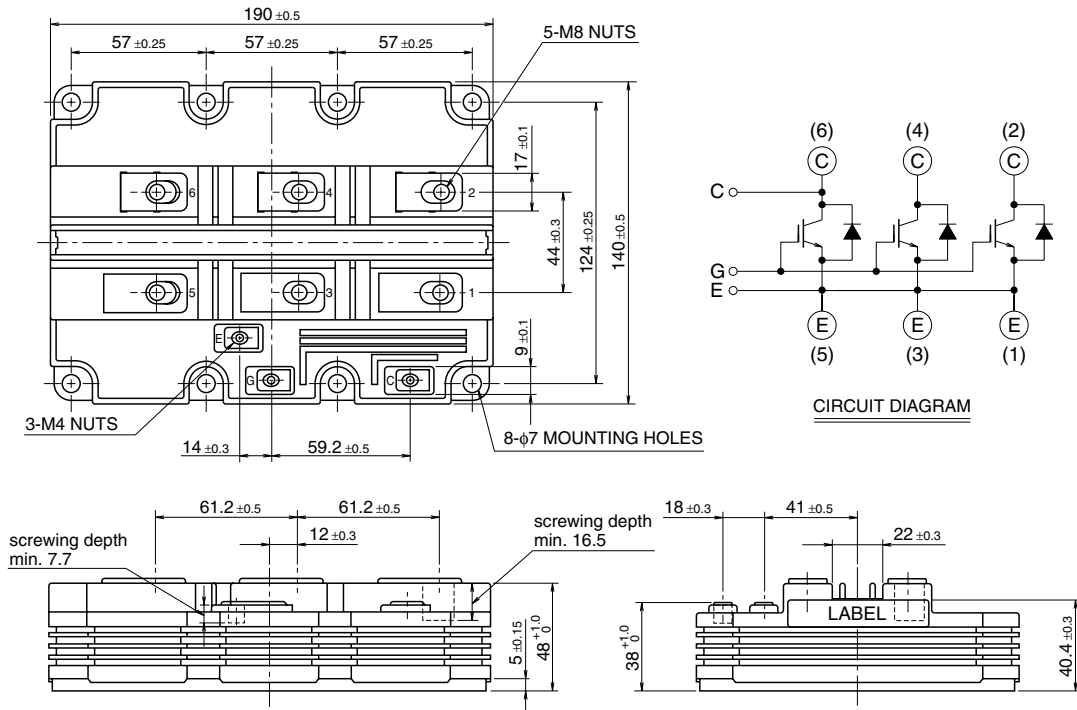
- IC ..... 600 A
- VCES ..... 6500 V
- High Insulated Type
- 1-element in a Pack
- AISiC Baseplate

**APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers

**OUTLINE DRAWING & CIRCUIT DIAGRAM**

Dimensions in mm



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May 2009



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**MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit	
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V	T <sub>J</sub> = -40°C	5800	V
			T <sub>J</sub> = +25°C	6300	
			T <sub>J</sub> = +125°C	6500	
V <sub>GES</sub>	Gate-emitter voltage	V <sub>CE</sub> = 0V, T <sub>J</sub> = 25°C	± 20	V	
I <sub>C</sub>	Collector current	DC, T <sub>c</sub> = 80°C	600	A	
I <sub>CM</sub>		Pulse (Note 1)	1200	A	
I <sub>E</sub>	Emitter current (Note 2)	DC	600	A	
I <sub>EM</sub>		Pulse (Note 1)	1200	A	
P <sub>c</sub>	Maximum power dissipation (Note 3)	T <sub>c</sub> = 25°C, IGBT part	8900	W	
V <sub>iso</sub>	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	10200	V	
V <sub>e</sub>	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q <sub>PD</sub> ≤ 10 pC	5100	V	
T <sub>J</sub>	Junction temperature		-40 ~ +150	°C	
T <sub>op</sub>	Operating temperature		-40 ~ +125	°C	
T <sub>stg</sub>	Storage temperature		-40 ~ +125	°C	
t <sub>psc</sub>	Maximum short circuit pulse width	V <sub>CC</sub> = 4500V, V <sub>CE</sub> ≤ V <sub>CES</sub> , V <sub>GE</sub> = 15V, T <sub>J</sub> = 125°C	10	μs	

**ELECTRICAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
I <sub>CES</sub>	Collector cutoff current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0V	T <sub>J</sub> = 25°C	—	—	10	mA
			T <sub>J</sub> = 125°C	—	30	90	
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 60 mA, T <sub>J</sub> = 25°C	5.0	6.0	7.0	V	
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0V, T <sub>J</sub> = 25°C	-0.5	—	0.5	μA	
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 10 V, V <sub>GE</sub> = 0 V, f = 100 kHz, T <sub>J</sub> = 25°C	—	124	—	nF	
C <sub>oes</sub>	Output capacitance		—	7.6	—	nF	
C <sub>res</sub>	Reverse transfer capacitance		—	2.2	—	nF	
Q <sub>g</sub>	Total gate charge		V <sub>CC</sub> = 3600 V, I <sub>C</sub> = 600 A, V <sub>GE</sub> = ±15 V, T <sub>J</sub> = 25°C	—	9.9	—	μC
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 600 A (Note 4) V <sub>GE</sub> = 15 V	T <sub>J</sub> = 25°C	—	4.50	—	V
			T <sub>J</sub> = 125°C	—	4.60	—	
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> = 3600 V, I <sub>C</sub> = 600 A, V <sub>GE</sub> = ±15 V R <sub>G(on)</sub> = 10 Ω, T <sub>J</sub> = 125°C, L <sub>s</sub> = 150 nH	—	1.20	—	μs	
t <sub>r</sub>	Turn-on rise time		—	0.35	—	μs	
E <sub>on(10%)</sub>	Turn-on switching energy (Note 5)	t <sub>(IGBT_off)</sub> = 60 μs <sup>(Note 6)</sup> , Inductive load	—	4.50	—	J/P	
t <sub>d(off)</sub>	Turn-off delay time	V <sub>CC</sub> = 3600 V, I <sub>C</sub> = 600 A, V <sub>GE</sub> = ±15 V R <sub>G(off)</sub> = 33 Ω, T <sub>J</sub> = 125°C, L <sub>s</sub> = 150 nH Inductive load	—	8.20	—	μs	
t <sub>f</sub>	Turn-off fall time		—	0.50	—	μs	
t <sub>f2</sub>	Turn-off fall time		—	3.10	—	μs	
E <sub>off(10%)</sub>	Turn-off switching energy (Note 5)		—	4.30	—	J/P	
V <sub>EC</sub>	Emitter-collector voltage (Note 2)	I <sub>E</sub> = 600 A (Note 4) V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25°C	—	4.00	—	V
			T <sub>J</sub> = 125°C	—	3.60	—	
t <sub>rr</sub>	Reverse recovery time (Note 2)	V <sub>CC</sub> = 3600 V, I <sub>E</sub> = 600 A, V <sub>GE</sub> = ±15 V R <sub>G(on)</sub> = 10 Ω, T <sub>J</sub> = 125°C, L <sub>s</sub> = 150 nH t <sub>(IGBT_off)</sub> = 60 μs <sup>(Note 6)</sup> , Inductive load	—	1.00	—	μs	
t <sub>rr2</sub>	Reverse recovery time (Note 2)		—	2.40	—	μs	
Q <sub>rr</sub>	Reverse recovery charge (Note 2)		—	1100	—	μC	
E <sub>rec(10%)</sub>	Reverse recovery energy (Note 2), (Note 5)		—	2.00	—	J/P	

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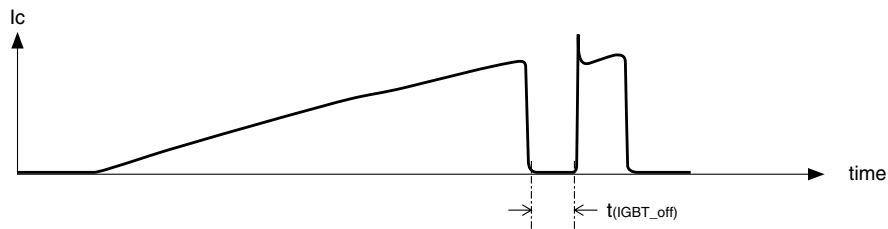
## THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part	—	—	14.0	K/kW
$R_{th(j-c)R}$	Thermal resistance	Junction to Case, FWDi part	—	—	22.0	K/kW
$R_{th(c-f)}$	Contact thermal resistance	Case to Fin, $\lambda_{grease} = 1W/m-K$ , $D(c-f) = 100 \mu m$	—	6.0	—	K/kW

## MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$M_t$	Mounting torque	M8: Main terminals screw	7.0	—	15.0	N·m
$M_s$		M6: Mounting screw	3.0	—	6.0	N·m
$M_t$		M4: Auxiliary terminals screw	1.0	—	3.0	N·m
m	Mass		—	1.35	—	kg
CTI	Comparative tracking index		600	—	—	—
$d_a$	Clearance		26	—	—	mm
$d_s$	Creepage distance		56	—	—	mm
LP CE	Internal inductance		—	17	—	nH
$R_{CC+EE}$	Internal lead resistance	$T_c = 25^\circ C$	—	0.14	—	mΩ

- Note 1. Pulse width and repetition rate should be such that junction temperature ( $T_j$ ) does not exceed  $T_{opmax}$  rating (125°C).  
 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).  
 3. Junction temperature ( $T_j$ ) should not exceed  $T_{jmax}$  rating (150°C).  
 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.  
 5.  $E_{on(10\%)} / E_{off(10\%)} / E_{rec(10\%)}$  are the integral of  $0.1V_{CE} \times 0.1I_c \times dt$ .  
 6.  $t_{(IGBT\_off)}$  definition is shown as follows.



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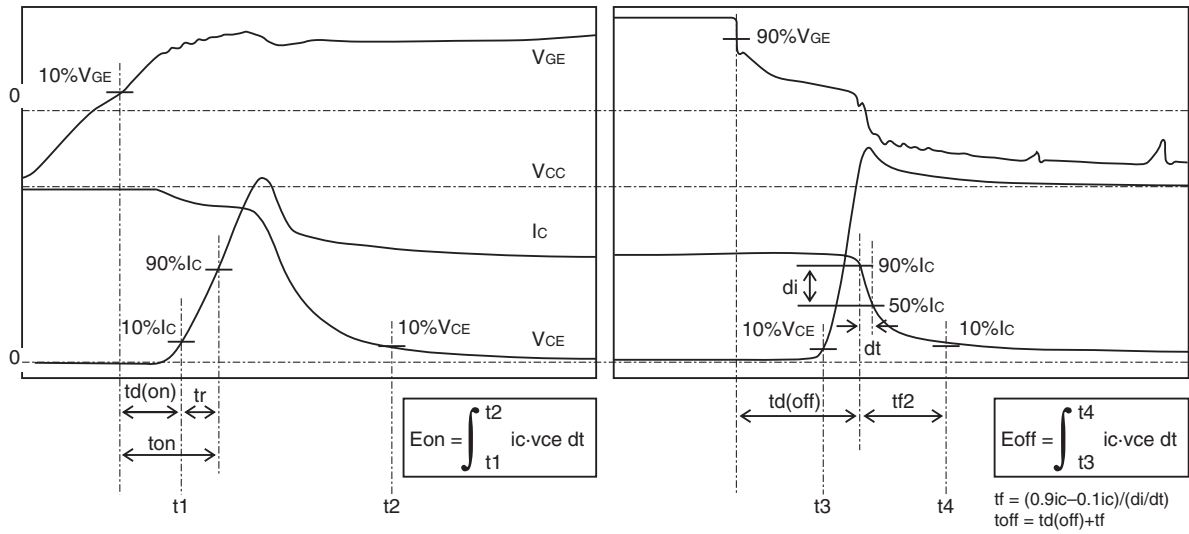


Fig. 1 – Definitions of switching times & energies of IGBT part

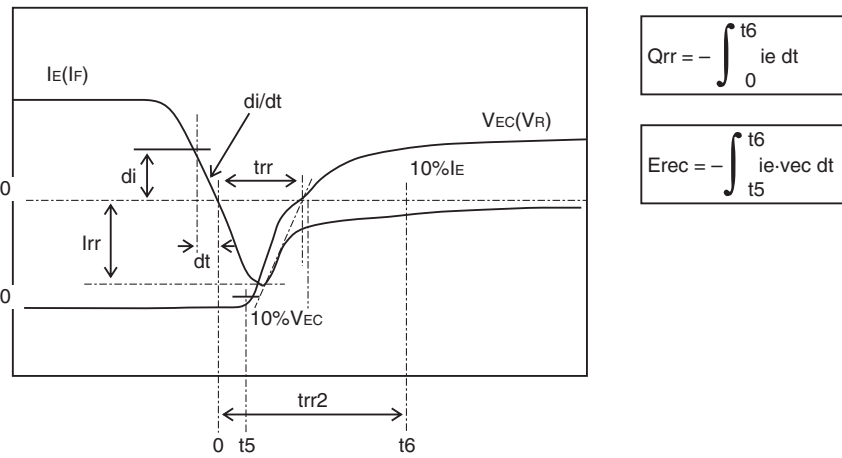


Fig. 2 – Definitions of reverse recovery charge & energy of FWDi part

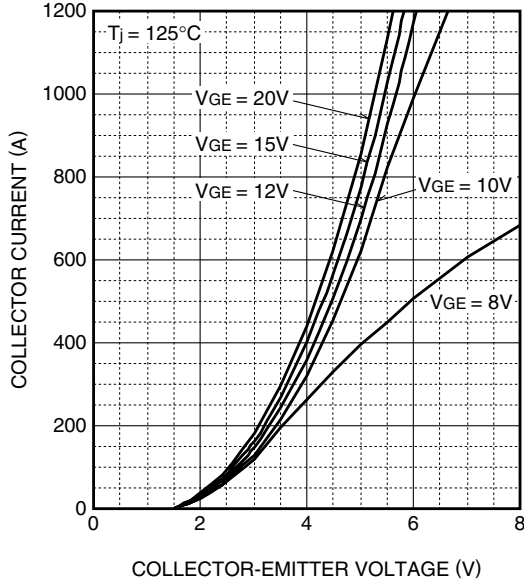
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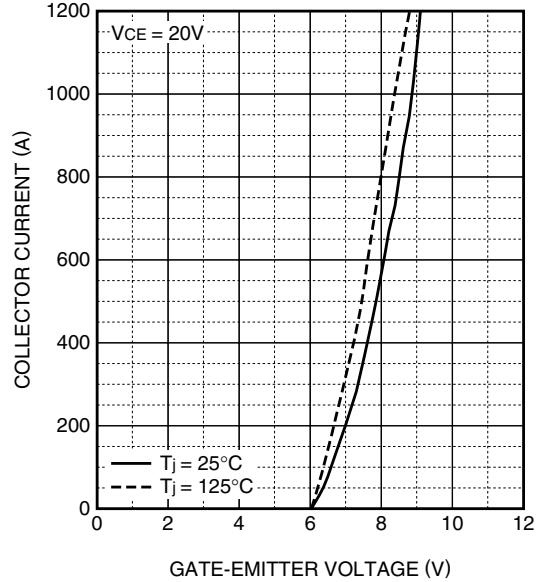
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## PERFORMANCE CURVES

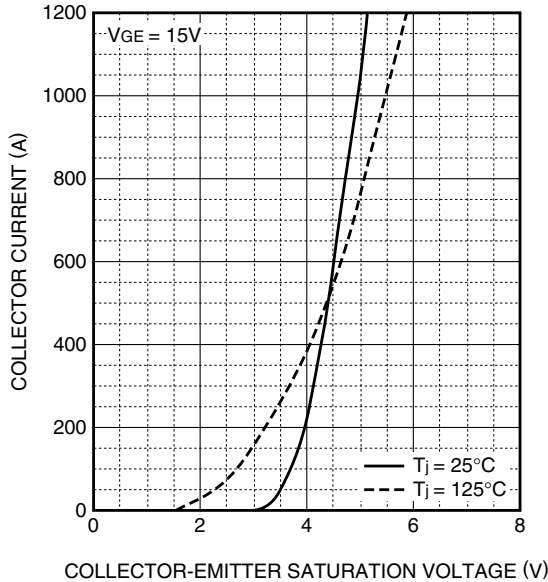
**OUTPUT CHARACTERISTICS (TYPICAL)**



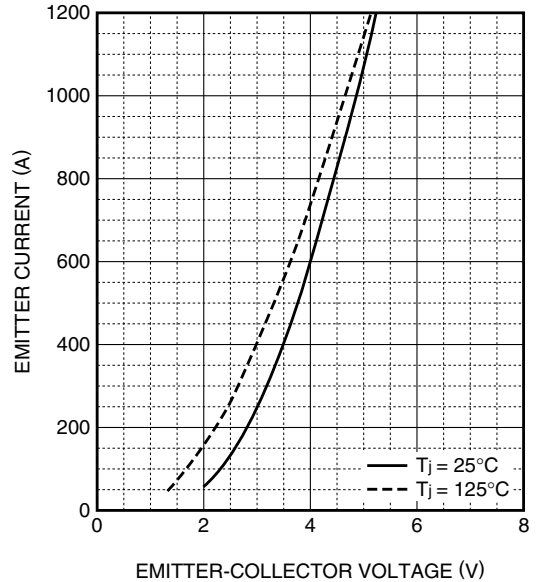
**TRANSFER CHARACTERISTICS (TYPICAL)**



**COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)**



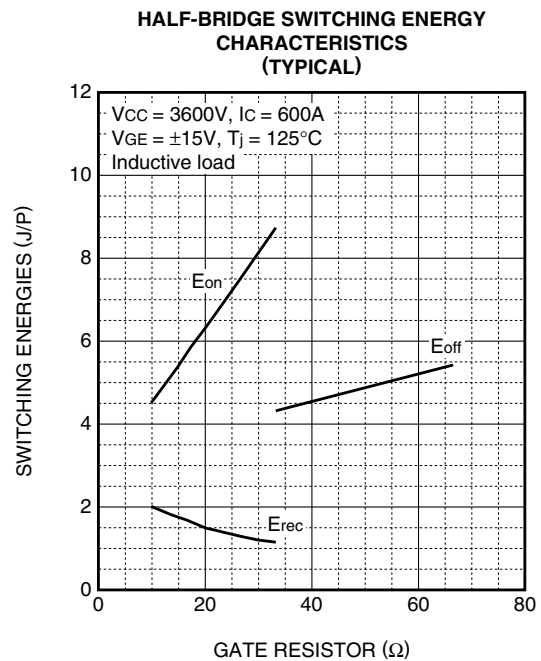
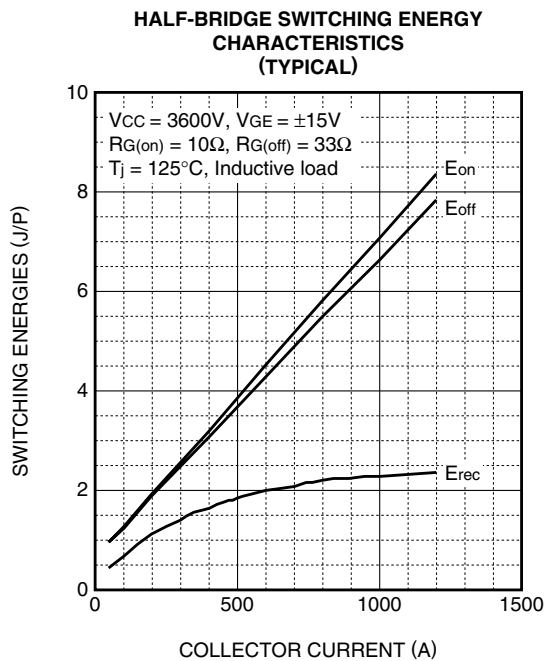
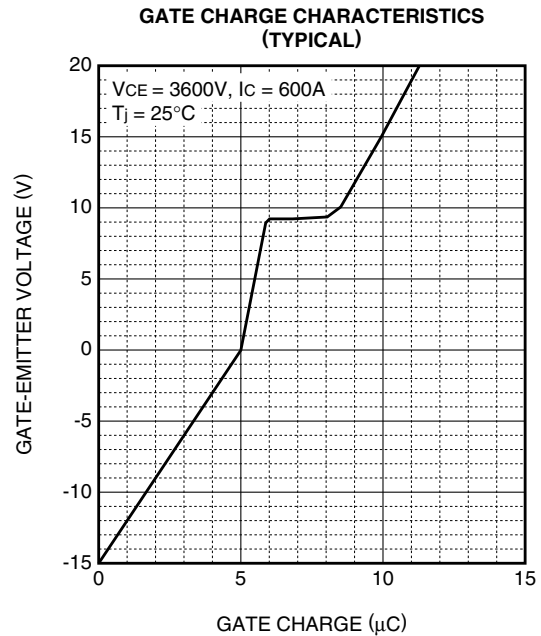
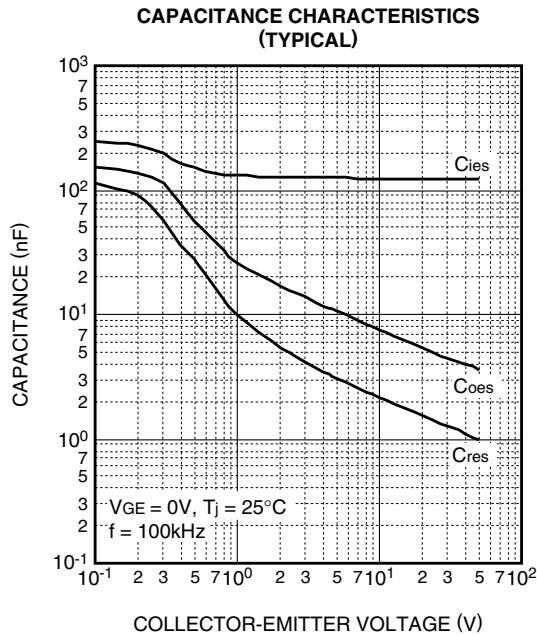
**FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)**



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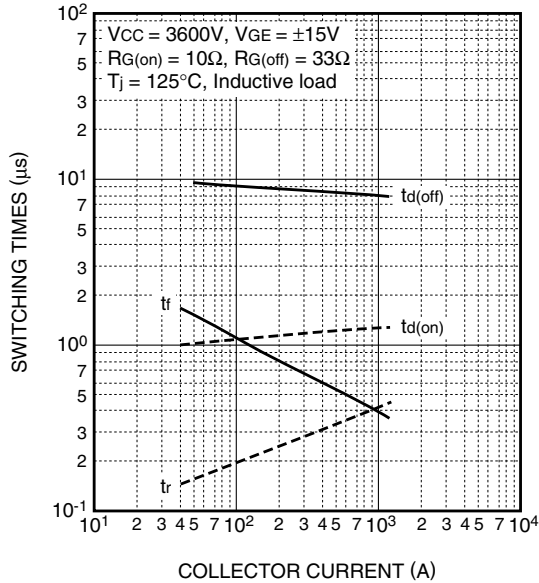


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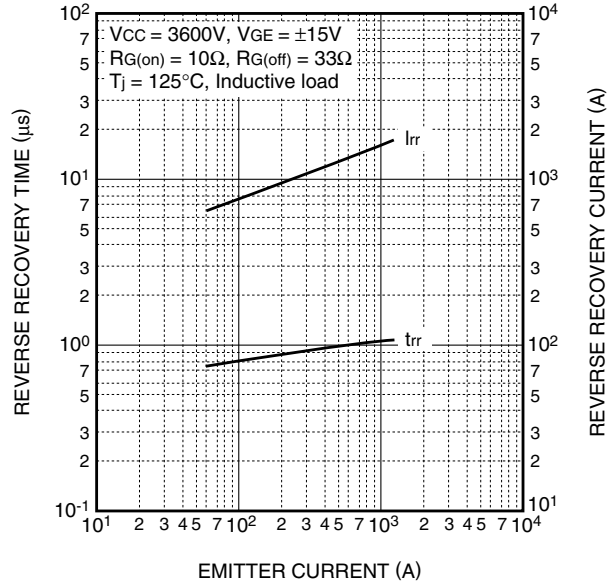
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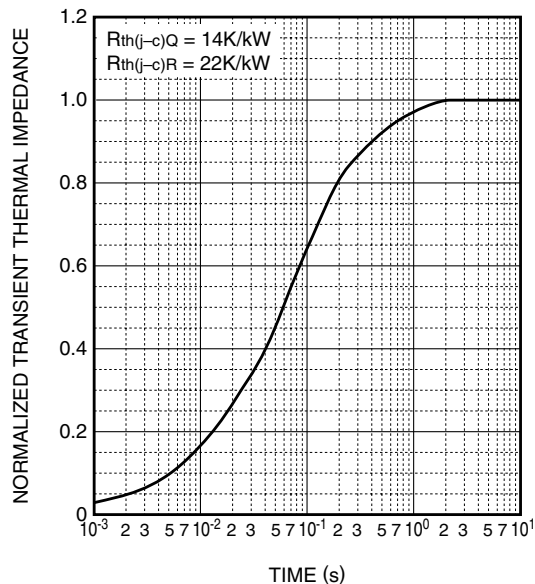
**HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)**



**FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)**



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS**



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

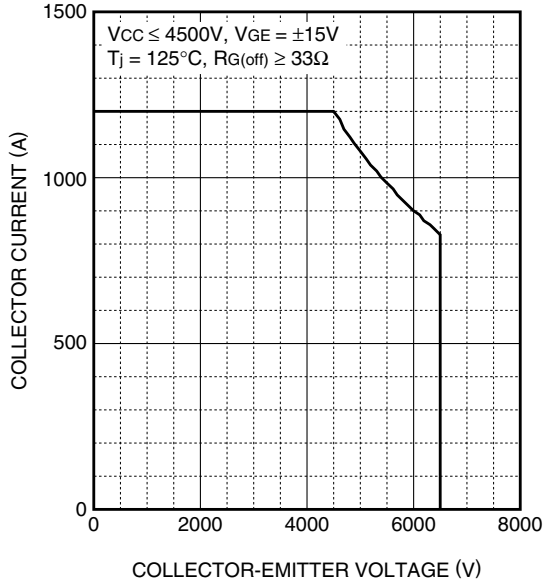
	1	2	3	4
$R_i$ [K/kW]	0.0059	0.0978	0.6571	0.2392
$\tau_i$ [sec]	0.0002	0.0074	0.0732	0.4488

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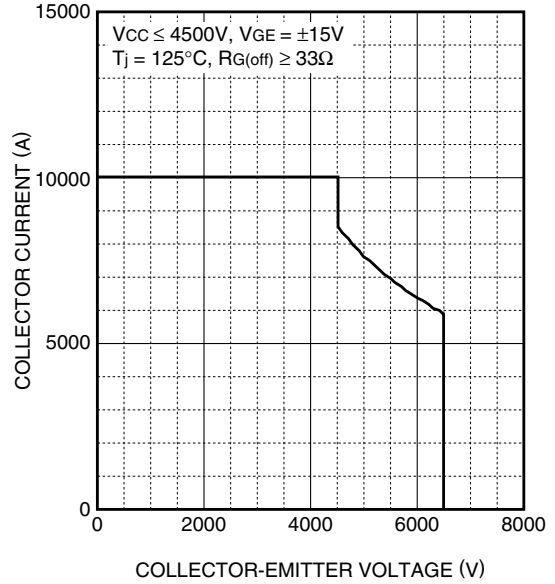
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**REVERSE BIAS SAFE OPERATING AREA (RBSOA)**



**SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)**



**FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)**

